

<b>Searched</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10516632	OSHIMA ET AL.
	Examiner Duong, Dieu Hien T	Art Unit 2821

Class	SubClass	Date	Examiner
343	700ms, 712, 713, 767, 770	10/16/06	DD

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